

650V 7A N-Channel Enhancement Mode Power MOSFET

Description

The AKT7N65T is an N-Channel enhancement mode power MOSFET which using proprietary planar stripe and DMOS technology.

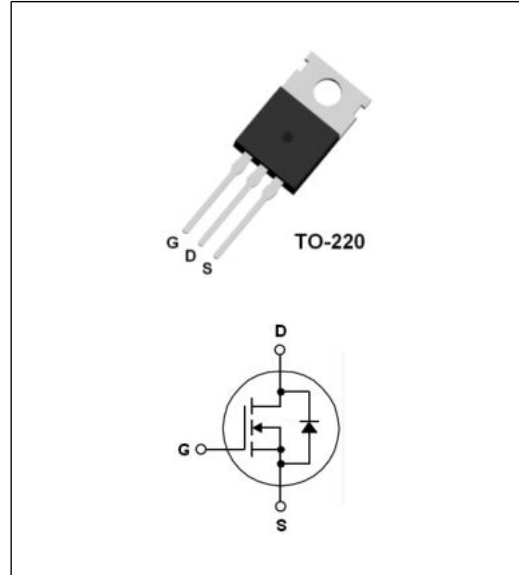
This MOSFET has low static on-resistance and high avalanche energy strength. This device provide excellent switching performance for UPS,DC-DC converters and AC-DC power supply.

Features

- Low on-Resistance: $R_{DS(on)}=1.13\Omega(\text{typ.})$
- Special Process Technology for high ESD Capability
- 100% Avalanche Test
- Good Stability and Uniformity with High E_{AS}

Applications

- UPS Applications
- DC-DC Converters and AC-DC Power Supply



Absolute Maximum Ratings @ $T_C=25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Unit |
|-----------|---|-------------------------|------------------|
| V_{DSS} | Drain to Source Voltage | 650 | V |
| V_{GSS} | Gate to Source Voltage | ± 30 | V |
| I_D | Drain Current | $T_C=25^\circ\text{C}$ | 7 |
| | | $T_C=100^\circ\text{C}$ | 4.4 |
| I_{DM} | Pulsed Drain Current (Note1) | 28 | A |
| P_D | Maximum Power Dissipation | $T_C=25^\circ\text{C}$ | 138 |
| | Derate above 25°C | | 1.11 |
| E_{AS} | Single Pulsed Avalanche Energy (Note 2) | 400 | mJ |
| T_J | Operating Junction Temperature Range | -55~+150 | $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | -55~+150 | $^\circ\text{C}$ |

Thermal Characteristics

| Symbol | Parameter | Ratings | Unit |
|---------------|---|---------|---------------------------|
| $R_{th(J-C)}$ | Thermal Resistance, Junction to case | 0.9 | $^\circ\text{C}/\text{W}$ |
| $R_{th(J-A)}$ | Thermal Resistance, Junction to Ambient | 62.5 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics @ $T_C=25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--------------|-----------------------------------|-------------------------------|------|------|-----------|----------|
| BV_{DSS} | Drain to Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 650 | - | - | V |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu A$ | 2.0 | - | 4.0 | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS}=10V, I_D=3.5A$ | - | 1.13 | 1.25 | Ω |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=650V, V_{GS}=0V$ | - | - | 1 | μA |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS}=\pm 30V, V_{DS}=0V$ | - | - | ± 100 | nA |

D-S Diode Characteristics and Maximum Rating @ $T_C=25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|---|----------------------|------|------|------|---------|
| I_S | Maximum Drain to Source Diode Forward Current | | - | - | 7 | A |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS}=0V, I_S=7A$ | - | 0.83 | 1 | V |
| t_{rr} | Reverse Recovery Time | $V_{GS}=0V, I_S=7A,$ | - | 490 | - | ns |
| Q_{rr} | Reverse Recovery Charge | $di/dt=-100A/\mu s$ | - | 3.2 | - | μC |

Switching Characteristics @ $T_C=25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--------------|------------------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on Delay Time | $I_D=7A,$ $V_{DD}=325V,$ $R_G=25\Omega$ (Note 3) | - | 50 | - | ns |
| t_r | Rising Time | | - | 150 | - | ns |
| $t_{d(off)}$ | Turn-off Delay Time | | - | 380 | - | ns |
| t_f | Falling Time | | - | 180 | - | ns |
| C_{iss} | Input Capacitance | $V_{GS}=0V, V_{DS}=25V,$ $f=1.0MHz$ | - | 1200 | - | pF |
| C_{oss} | Output Capacitance | | - | 145 | - | pF |
| C_{riss} | Reverse Transfer Capacitance | | - | 40 | - | pF |
| Q_g | Total Gate Charge | $I_D=7A,$ $V_{DS}=520V$ $V_{GS}=10V$ (Note 3) | - | 29 | - | nC |
| Q_{gs} | Gate to Source Charge | | - | 8.6 | - | nC |
| Q_{gd} | Gate to Drain Charge | | - | 18.9 | - | nC |

Note:

1. Repetitive rating: pulse-width limited by maximum junction temperature
2. $L=20mH, V_{DD}=100V, V_G=10V, @T_C=25^\circ C$
3. Essentially independent of operating temperature typical characteristics

Typical Performance Characteristics

Fig. 1. Typical on-Region Characteristics

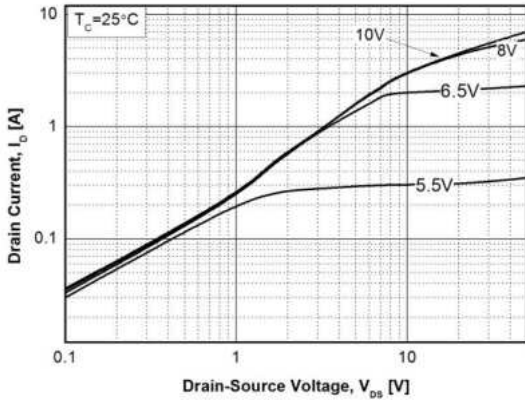


Fig. 2. Typical Transfer Characteristics

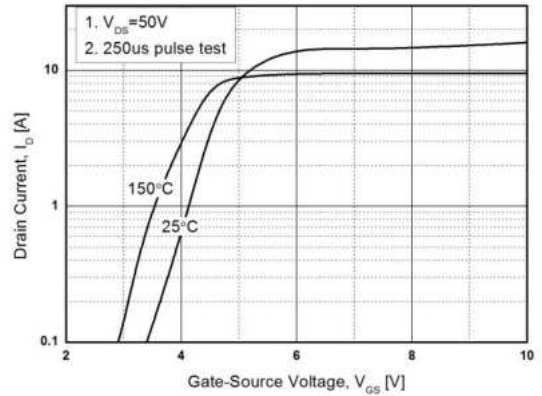


Fig. 3. Static on-Resistance vs. I_D

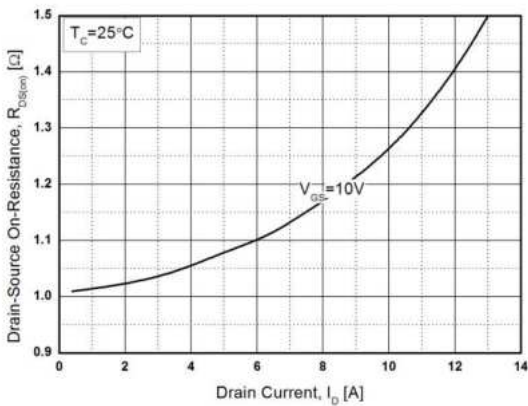


Fig. 4. Body Diode Forward Voltage vs. I_{DR}

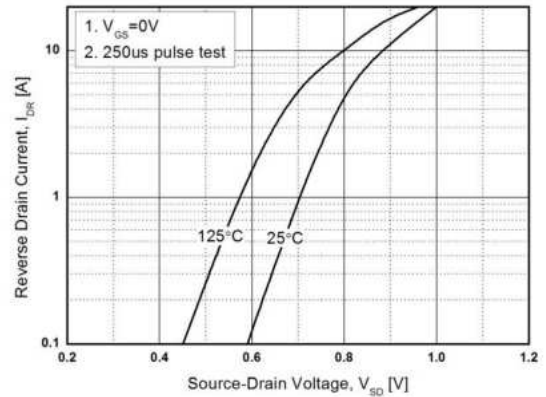


Fig. 5. Capacitance Characteristics

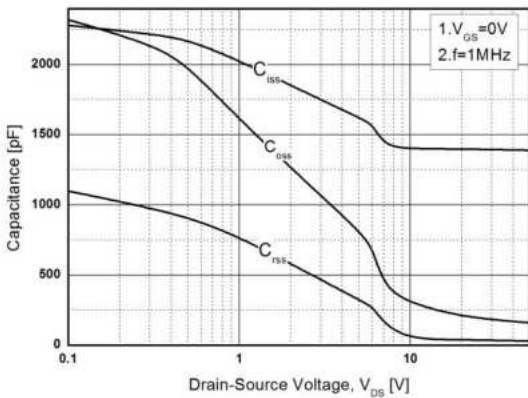
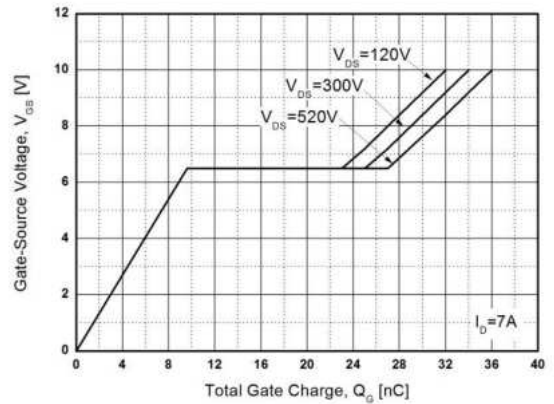


Fig. 6. Gate Charge Characteristics



Typical Performance Characteristics

Fig. 7. Breakdown Voltage vs. Temperature

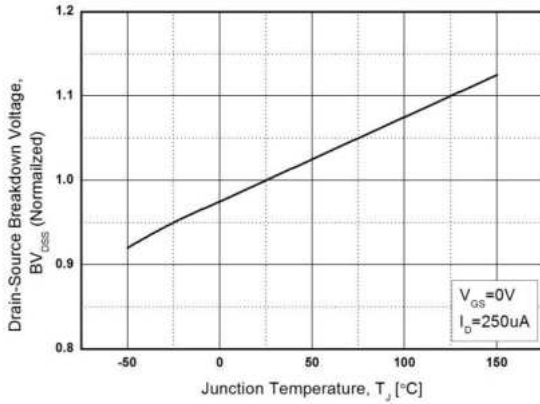


Fig. 8. Static on-Resistance vs. Temperature

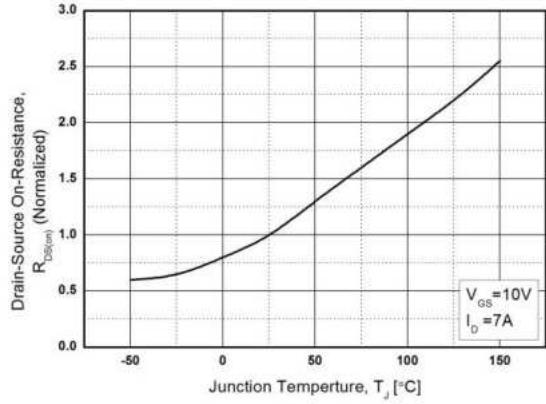


Fig. 9. Maximum Safe Operating Area

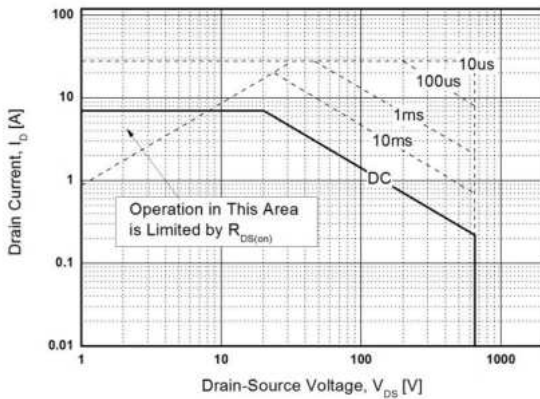


Fig. 10. Maximum Drain Current vs. Temperature

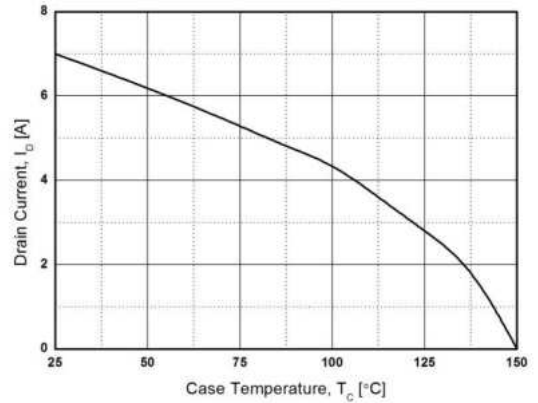


Fig. 11. Transient Thermal Response Curve

